20 STERN AVE. SPRINGFIELD, NEW JERSEY 07081 U.S.A. 2N 5001 (SILICON) 30 WATT PNP POWER TRANSISTOR TELEPHONE: (973) 376-2922 (212) 227-6005 FAX: (973) 376-8960



ELECTRICAL CHARACTERISTICS (25° Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNITS	TEST CO	NDITIONS
V _{CEO} (sust)	Collector to Emitter Sustaining Voltage (Notes 2 and 3)	80			Valts	$I_{\rm C} = 100 {\rm mA}$	l ₈ = 0
BVCES	Collector to Emitter Breakdown Voltage	100			Volts	$I_{\rm C}=1.0~{\rm mA}$	$V_{BE} = 0$
BV _{EBO}	Emitter to Base Breakdown Voltage	6.0			Volts	$l_{\rm C} = 0$	$I_{\rm E} = 1.0 \rm mA$
h _{FE}	DC Pulse Current Gain (Note 3)	50	120			$I_{\rm C} = 50 \rm{mA}$	$V_{CE} = 5.0 V$
h _{FE}	DC Pulse Current Gain (Note 3)	70	110	200		$I_{\rm C} = 1.0$ A	$V_{CE} = 5.0 V$
h _{FE} (-55°C)	DC Pulse Current Gain (Note 3)	35	63			$h_{\rm C} = 1.0 {\rm A}$	$V_{CE} = 5.0 V$
h _{FE}	DC Pulse Current Gain (Note 3)	30	56			$I_{c} = 2.0 \text{ A}$	$V_{CE} = 5.0 V$
h _{fe}	High Frequency Current Gain ($f = 20$ MHz)	3.0	4.3			$I_{\rm C} = 0.2$ A	V _{CF} == 5.0 V
V _{CE} (sat)	Pulsed Collector Saturation Voltage (Note 3)		0.38	0.46	Volts	$I_{\rm C} = 1.0 {\rm A}$	$I_{B} = 0.1 \text{ A}$
V _{CE} (sat)	Pulsed Collector Saturation Voltage (Note 3)		0.75	0.85	Volts	$I_{\rm C} = 2.0$ Å	$l_{\rm B} = 0.2$ A
V _{BE} (sat)	Pulsed Base Saturation Voltage (Note 3)		0.98	1.2	Volts	$I_{\rm C} = 1.0 {\rm A}$	$I_{\rm R} = 0.1 {\rm A}$
V _{8E} (sat)	Pulsed Base Saturation Voltage (Note 3)		1.30	1.5	Volts	Ι _C = 2.0 A	$l_{\rm B} = 0.2 {\rm A}$
V _{BE} (on)	Pulsed Base Emitter "ON" Voltage (Note 3)			1.5	Volts	$l_{c} = 2.0 \text{ A}$	$V_{CF} = 5.0 V$
ICES	Collector Cutoff Current		.002	1.0	μA	$V_{C5} = 60 V$	$V_{\rm pc} = 0$
I EBO	Emitter Gutoff Current			1.0	μA	ر اہے ≕ 0	$V_{co} = 5.0 V$
I _{CEX} (150°C)	Collector Reverse Current			500	μ Α	$V_{c_{\rm F}} = 60 V$	$V_{r_{R}} = 2.0 V$
C _{cb}	Collector to Base Capacitance		30	70	pF	$I_{\rm E} = 0$	$V_{CB} = 10 V$

NOTES:

(1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.

(2) This rating refers to a high current point where collector to emitter voltage is lowest.

(3) Pulse Conditions: length = 300μ s; duty cycle = 1%.

(4) Contact factory for maximum permissible power under pulsed or reverse biased operating conditions.